## Applicant(s)/Patent Under Application/Control No. Reexamination 09/898,386 CHEN ET AL. Notic of References Cit d Art Unit Examiner Page 1 of 1 2811 ori nadav **U.S. PATENT DOCUMENTS** Date **Document Number** Classification Name Country Code-Number-Kind Code MM-YYYY 257/546 Chen et al. US-6016002 01-2000 Α 357/42 04-1982 Uchida US-4327368 В

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	5-90520	04-1993	Jp	Murakami	H01L27/092
	0					
	Р					
	ď					
	R					
	S					
	Т				,	

## **NON-PATENT DOCUMENTS**

	NON-PATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	υ						
	٧						
	w						
	х						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

С

D

Ε

F

G

Н

ı

Κ

L

М

US-US-

US-

US-

US-

US-

US-

US-

US-US-

US-

1